

Power MOSFET, 40 A



SOT-227

PRODUCT SUMMARY	
V_{DSS}	500 V
$R_{DS(on)}$ (typical)	0.084 Ω
I_D	40 A
Type	Modules - MOSFET
Package	SOT-227

FEATURES

- Low gate charge Q_g results in simple drive requirement
- Improved gate, avalanche and dynamic dV/dt ruggedness
- Fully characterized capacitance and avalanche voltage and current
- Low $R_{DS(on)}$
- Fully insulated package
- UL pending
- Compliant to RoHS directive 2002/95/EC
- Designed and qualified for industrial level



APPLICATIONS

- Switch mode power supply (SMPS)
- Uninterruptible power supply
- High speed power switching
- Hard switched and high frequency circuits

ABSOLUTE MAXIMUM RATINGS				
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS
Continuous drain current, V_{GS} at 10 V	I_D	$T_C = 25^\circ\text{C}$	40	A
Pulsed drain current		$T_C = 100^\circ\text{C}$	26	
Pulsed drain current	$I_{DM}^{(1)}$		160	
Power dissipation	P_D	$T_C = 25^\circ\text{C}$	430	W
Linear derating factor			3.45	W/ $^\circ\text{C}$
Gate to source voltage	V_{GS}		± 30	V
Peak diode recovery dV/dt	$dV/dt^{(2)}$		9.0	V/ns
Operating junction and storage temperature range	T_J, T_{Stg}		-55 to +150	$^\circ\text{C}$

Notes

(1) Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

(2) $I_{SD} \leq 40$ A, $dI/dt \leq 150$ A/ μs , $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 150^\circ\text{C}$

AVALANCHE CHARACTERISTICS				
PARAMETER	SYMBOL	TYP.	MAX.	UNITS
Single pulse avalanche energy	$E_{AS}^{(1)}$	-	1240	mJ
Avalanche current	$I_{AR}^{(2)}$	-	40	A
Repetitive avalanche energy	$E_{AR}^{(2)}$	-	43	mJ

Notes

(1) Starting $T_J = 25^\circ\text{C}$, $L = 1.55$ mH, $R_g = 25 \Omega$, $I_{AS} = 40$ A, $dV/dt = 5.5$ V/ns (see fig. 12a)

(2) Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

THERMAL RESISTANCE

PARAMETER	SYMBOL	TYP.	MAX.	UNITS
Junction to case	R _{thJC}	-	0.29	°C/W
Case to sink, flat, greased surface	R _{thCS}	0.05	-	

STATIC CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Drain to source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA	500	-	-	V
Breakdown voltage temperature coefficient	ΔV _{(BR)DSS} /ΔT _J	Reference to 25 °C, I _D = 1 mA	-	0.60	-	V/°C
Static drain to source on-resistance	R _{DS(on)} ⁽¹⁾	V _{GS} = 10 V, I _D = 24 A	-	0.084	0.10	Ω
Gate threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Drain to source leakage current	I _{DSS}	V _{DS} = 500 V, V _{GS} = 0 V V _{DS} = 400 V, V _{GS} = 0 V, T _J = 125 °C	-	-	50	μA
Gate to source forward leakage	I _{GSS}	V _{GS} = 30 V	-	-	250	
Gate to source reverse leakage		V _{GS} = -30 V	-	-	- 250	nA

Note

(1) Pulse width ≤ 300 μs; duty cycle ≤ 2 %

DYNAMIC CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Forward transconductance	g _f	V _{DS} = 50 V, I _D = 28 A	23	-	-	S
Total gate charge	Q _g ⁽¹⁾	I _D = 40 A V _{DS} = 400 V V _{GS} = 10 V; see fig. 6 and 13	-	-	270	nC
Gate to source charge	Q _{gs} ⁽¹⁾		-	-	84	
Gate to drain ("Miller") charge	Q _{gd} ⁽¹⁾		-	-	130	
Turn-on delay time	t _{d(on)} ⁽¹⁾		-	25	-	ns
Rise time	t _r ⁽¹⁾	V _{DD} = 250 V I _D = 40 A R _g = 1.0 Ω V _{GS} = 10 V, see fig. 10	-	140	-	
Turn-off delay time	t _{d(off)} ⁽¹⁾		-	55	-	
Fall time	t _f ⁽¹⁾		-	74	-	
Input capacitance	C _{iss}	V _{GS} = 0 V V _{DS} = 25 V f = 1.0 MHz, see fig. 5	-	8310	-	pF
Output capacitance	C _{oss}		-	960	-	
Reverse transfer capacitance	C _{rss}		-	120	-	
Output capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 1.0 V, f = 1.0 MHz	-	10 170	-	
		V _{GS} = 0 V, V _{DS} = 480 V, f = 1.0 MHz	-	240	-	
Effective output capacitance	C _{oss} eff. ⁽²⁾	V _{GS} = 0 V, V _{DS} = 0 V to 480 V	-	440	-	

Notes

(1) Pulse width ≤ 300 μs; duty cycle ≤ 2 %

(2) C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80 % V_{DSS}

DIODE CHARACTERISTICS						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Continuous source current (body diode)	I_S	MOSFET symbol showing the integral reverse p-n junction diode	-	-	40	A
Pulsed source current (body diode)	I_{SM} (1)		-	-	160	
Diode forward voltage	V_{SD} (2)	$T_J = 25^\circ\text{C}$, $I_S = 40 \text{ A}$, $V_{GS} = 0 \text{ V}$	-	-	1	V
Reverse recovery time	t_{rr} (2)	$T_J = 25^\circ\text{C}$, $I_F = 47 \text{ A}$; $dI/dt = 100 \text{ A}/\mu\text{s}$	-	620	940	ns
Reverse recovery charge	Q_{rr}	$T_J = 25^\circ\text{C}$, $I_F = 47 \text{ A}$; $dI/dt = 100 \text{ A}/\mu\text{s}$	-	14	21	μC
Reverse recovery current	I_{RRM}	$T_J = 25^\circ\text{C}$	-	38	-	A
Forward turn-on time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Notes

(1) Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

(2) Pulse width $\leq 300 \mu\text{s}$; duty cycle $\leq 2\%$

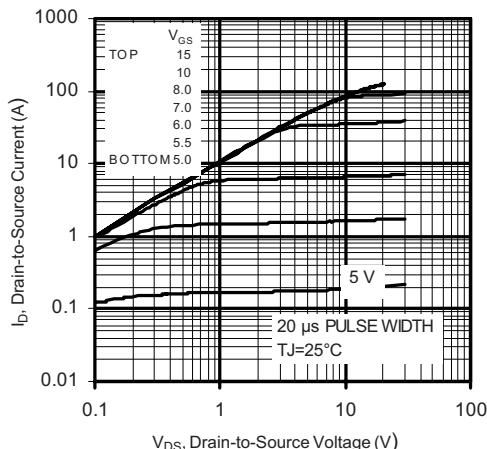


Fig. 1 - Typical Output Characteristics

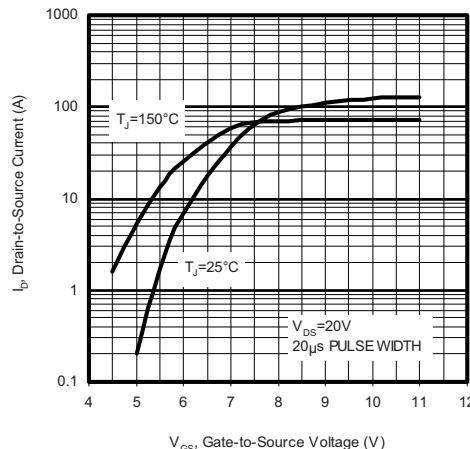


Fig. 3 - Typical Transfer Characteristics

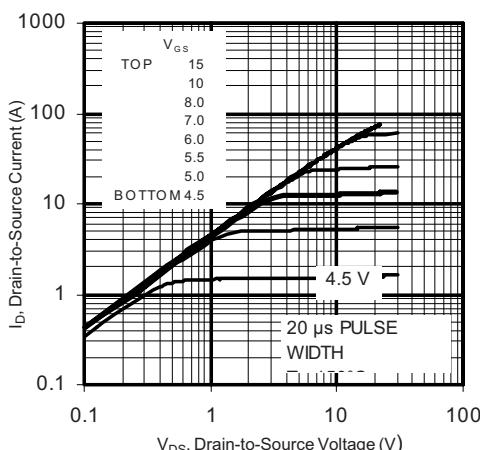


Fig. 2 - Typical Output Characteristics

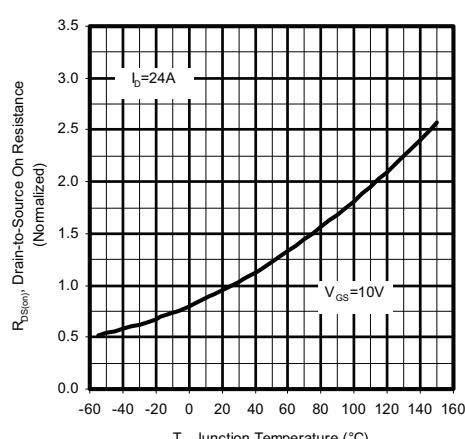


Fig. 4 - Normalized On-Resistance vs. Temperature

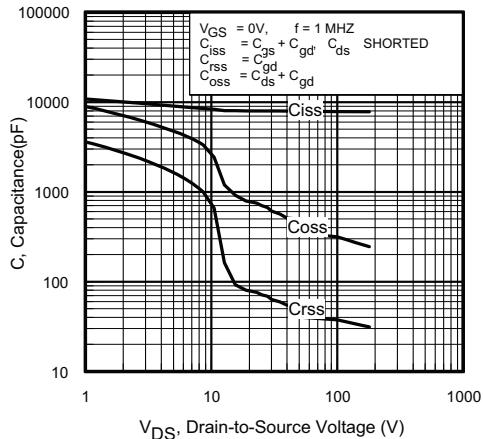
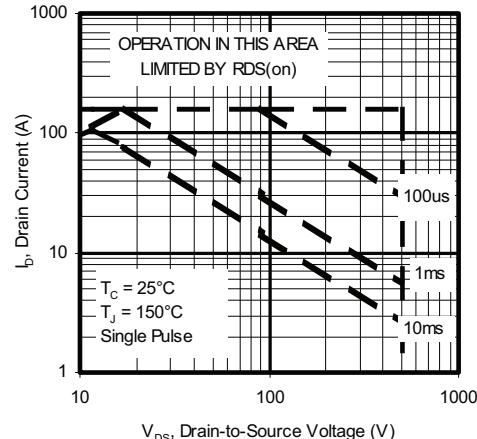
Fig. 5 - Typical Capacitance vs.
Drain to Source Voltage

Fig. 8 - Maximum Safe Operating Area

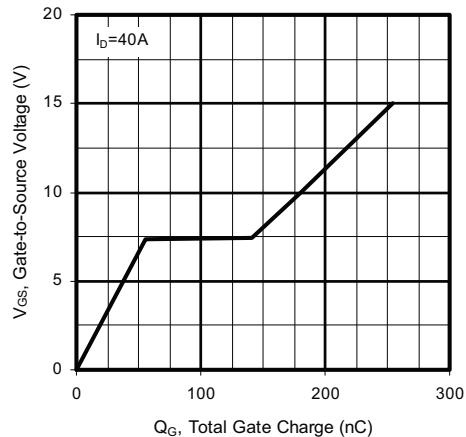
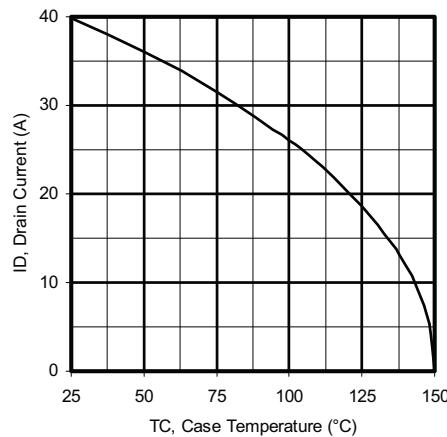
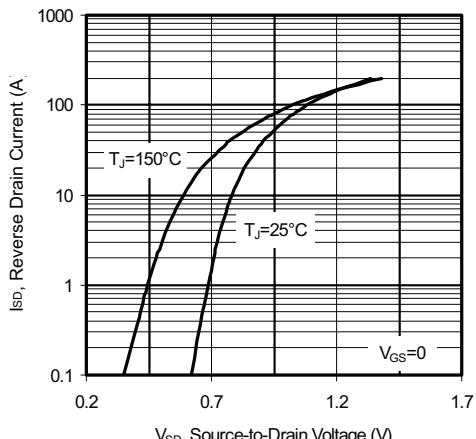
Fig. 6 - Typical Gate Charge vs.
Gate to Source VoltageFig. 9 - Maximum Drain Current vs.
Case Temperature

Fig. 7 - Typical Source Drain Diode Forward Voltage

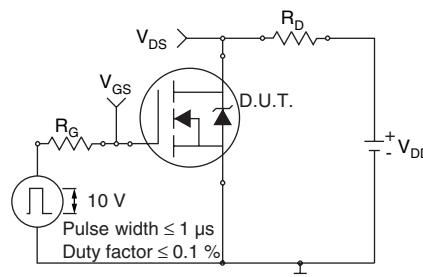


Fig. 10a - Switching Time Test Circuit

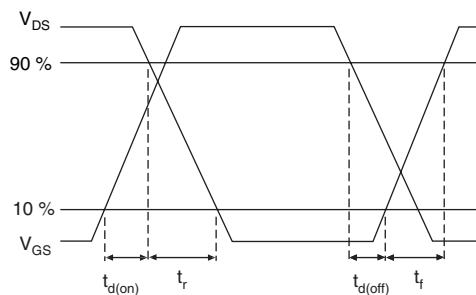


Fig. 10b - Switching Time Waveforms

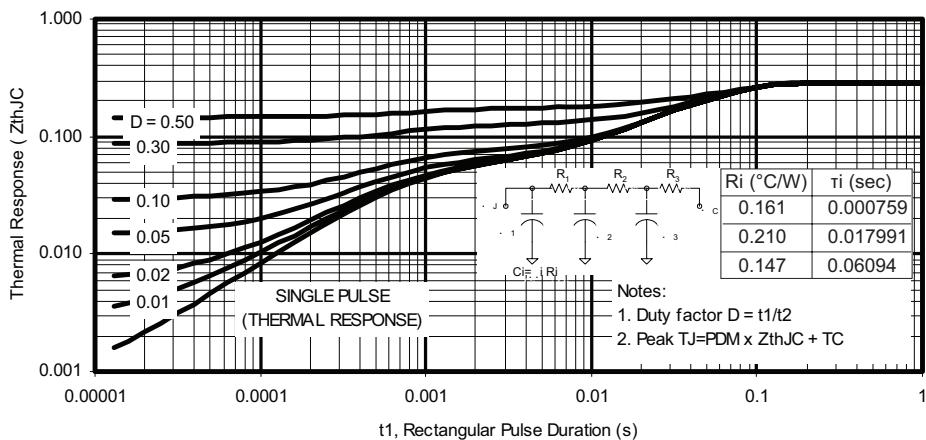


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction to Case

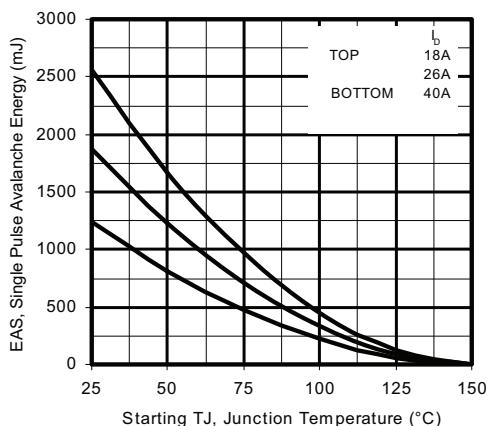


Fig. 12a - Maximum Avalanche Energy vs. Drain Current

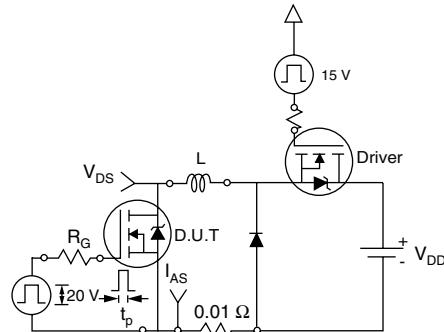


Fig. 12b - Unclamped Inductive Test Circuit

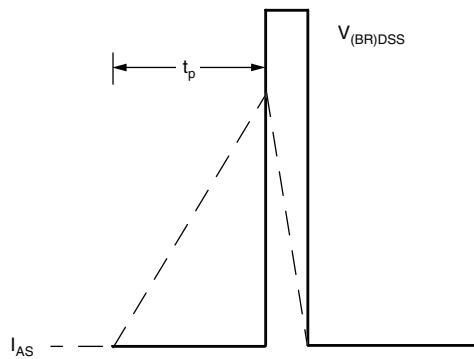


Fig. 12c - Unclamped Inductive Waveforms

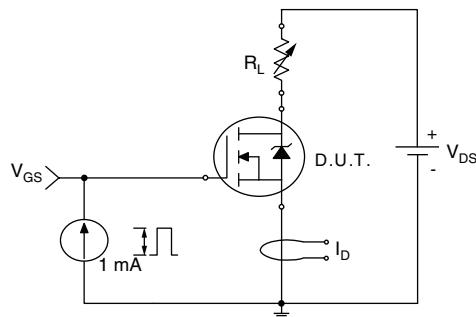


Fig. 13a - Gate Charge Test Circuit

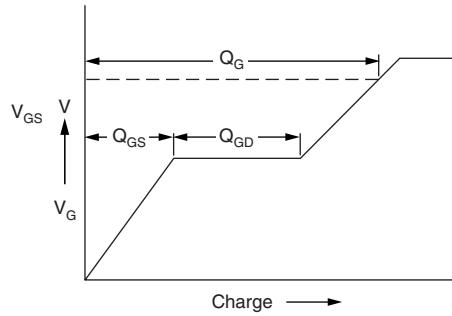


Fig. 13b - Basic Gate Charge Waveform

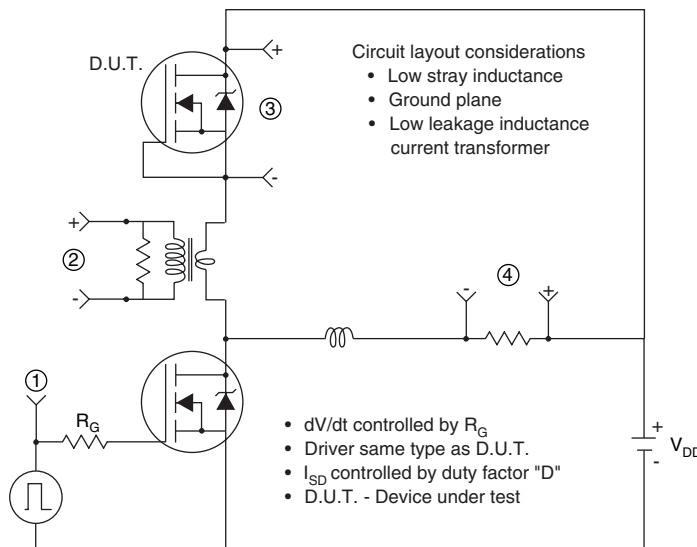


Fig. 13c - Peak Diode Recovery dV/dt Test Circuit

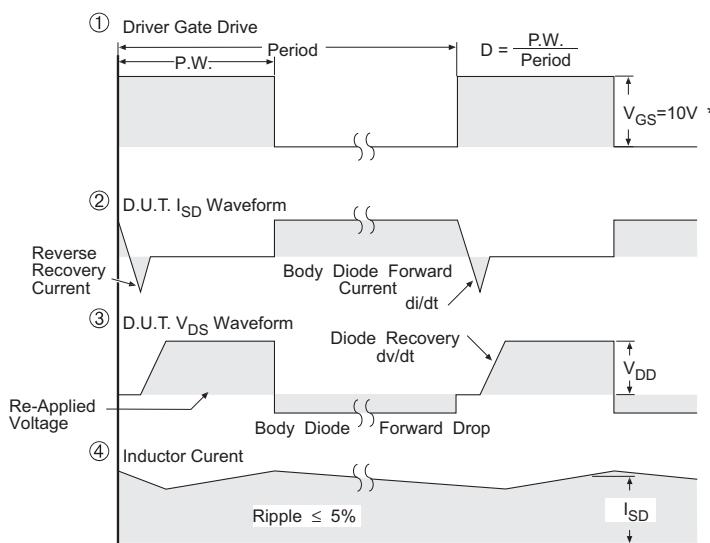
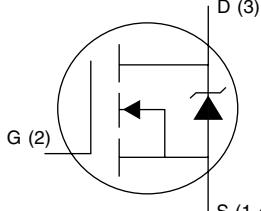
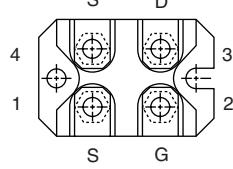


Fig. 14 - For N-Channel Power MOSFETs

ORDERING INFORMATION TABLE

Device code	F	C	40	S	A	50	FK	P
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
1	- Power MOSFET							
2	- Generation 6.2/6.3 MOSFET silicon DBC construction							
3	- Current rating (40 = 40 A)							
4	- Single switch (see Circuit Configuration table)							
5	- SOT-227							
6	- Voltage rating (50 = 500 V)							
7	- MOSFET K speed							
8	<ul style="list-style-type: none"> • None = Standard production • P = Lead (Pb)-free 							

CIRCUIT CONFIGURATION		
CIRCUIT	CIRCUIT CONFIGURATION CODE	CIRCUIT DRAWING
Single switch no diode	S	 <p>Lead assignment</p> 

LINKS TO RELATED DOCUMENTS	
Dimensions	www.vishay.com/doc?95036
Packaging information	www.vishay.com/doc?95037

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